



# TESTLINE

## Die-level photonic device test

Semi and fully automated, mixed-signal electro-optical test systems for optoelectronics and singulated photonic devices. Featuring DC, RF and optical measurements in a production-optimized modular layout. Targeted at R&D, volume manufacturing and anything in between.



### Highlights

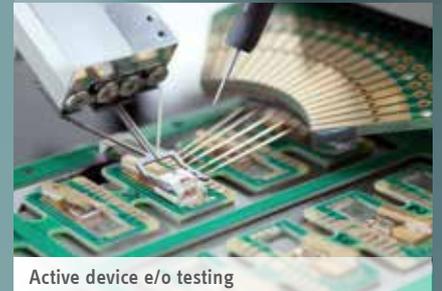
- ✓ State-of-the-art, mixed-signal electro-optical probing
- ✓ Fast machine vision for precision I/O probe-to-port alignment
- ✓ Designed for all optoelectronic devices and PIC material systems
- ✓ Applications in PIC hybridization, sensors & lidar, copackaging

## Automated die-level electro-optical test

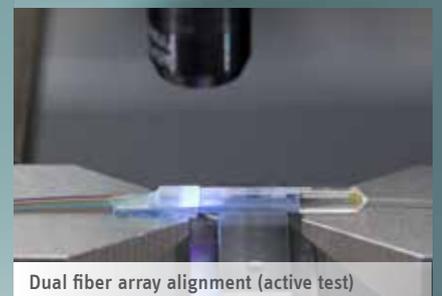
ficonTEC's TESTLINE production systems are fully automated solutions for electro-optical testing of optoelectronic devices and of singulated PICs (passive/active). Other complex tasks include LIV, spectral and near/far-field beam characterization of single laser chips (incl. VCSELs), unmounted laser diode bars and chip-on-submount (CoS) sources. Lastly, TESTLINE systems can be routinely equipped to also perform detailed optical facet inspection using Deep Learning for defect recognition.

Stand-alone systems are designed to provide as much multi-functional test-&-qualify capability as possible and are best suited to complex testing requirements requiring multiple capabilities within a single machine. This makes the stand-alone systems ideal for test development and for batch processing requirements.

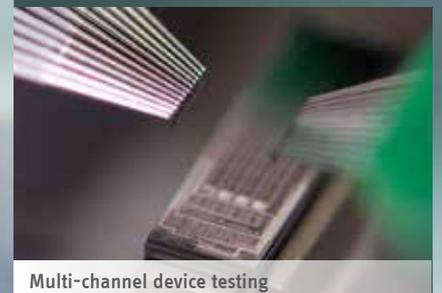
ficonTEC's next-generation in-line system architecture is designed to be production-line-capable from the ground up. By utilizing state-of-the-art component handling and feed in/out options, TESTLINE, ASSEMBLYLINE and other systems can be combined in a task-optimized production line configuration to provide volume manufacturing.



Active device e/o testing



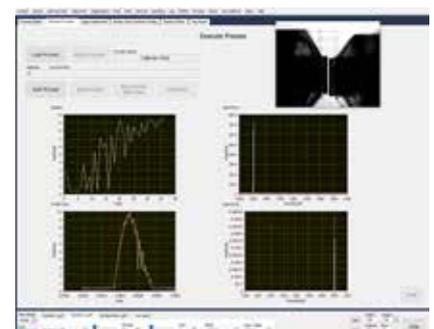
Dual fiber array alignment (active test)



Multi-channel device testing

## Software control

PCM is ficonTEC's unified process-oriented control interface that ships with all turn-key stand-alone systems and multiple machine configurations. PCM features an intuitive UI and an up-to-date feature set that includes all machine vision, high-resolution positioning, system management software and test routines required to reliably and repeatably drive passive/active alignment and bonding process hardware.



Spectral and beam characterization functions displayed in real time



# TESTLINE

## Die-level photonic device test



Simultaneous high-speed testing



High-resolution facet inspection

### Key features

- High-precision motion referencing and alignment
- Pick-&-place from/to standard/custom carrier formats
- Die-level handling, testing and sorting as required
- Fiber alignment to I/O ports (arrays) in max. 4s
- Low-loss I/O port coupling with < 0.4 dB repeatability

### General tasks & applications

- Rapid R&D, in-line & end-of-line device testing
- Optical facet inspection with AI defect recognition
- Optoelectronic, HPLD, MOEMS and sensor assemblies
- Camera modules, 3D scanning & lidar, PICs & silicon photonics
- Configurable for high-complexity copackaged applications



### Modular & (re-)configurable

- State-of-the-art die and carrier handling options
- Optional modules expand operational functionality
- Operate, monitor and sync parallel lines remotely
- Add and/or swap modules to re-configure & re-purpose

## MANUFACTURING MADE LIGHT

Solutions for integrated photonics. Built to scale.

ficonTEC is the global market leader for automated assembly and test solutions for modern optoelectronics and integrated photonic devices. In serving development and manufacturing needs for telecom/datacom interconnects, sensors & lidar, camera modules, high-power diode lasers and many other integrated applications for over 20 years, ficonTEC's suite of process capabilities is unmatched.

Additionally, a unique and modular approach to production equipment design means that each solution is the automated and optimized embodiment of a customer-defined process.

### Contact us

ficonTEC Service GmbH  
Achim, Germany

T +49 4202 51160-0  
info@ficontec.com

For ficonTEC subsidiaries in the US and Far East as well as for distributors around the globe:



[www.ficontec.com/locations](http://www.ficontec.com/locations)

Core system specifications	 T800	 T1200	 T1600	 T2000
Motion system	single optical probing with 6-axis high-precision alignment* electrical probing with 3-axis alignment		multiple optical probing with 6-axis high-precision alignment* electrical probing with 3-axis alignment	
Device handling	pick-&-place from/to Gel-Pak, Waffle Pack & custom		pick-&-place from/to Gel-Pak, Waffle Pack, blue tape & custom	
Temperature control	temperature-controlled chuck, +15 to +80 (+/- 0.1) °C			
Handling options	manual loading and/or single conveyor		automated loading with single or dual conveyor	
Machine vision	system referencing and observation camera options   device and I/O port referencing			
Software features	flexible and powerful process programming   extended operator-less control   Windows 10 PC			
Minimum connections	120 VAC (or country specific)   air/vacuum   100 Mbit/s network			
Cleanroom compliance	ISO 6**			
Physical features	rugged steel base production cell			
Dimensions (w x b x h, mm)	800 x 1200 x 1600/2000	1200 x 1200 x 2000	1600 x 1200 x 2000	1800 x 1200 x 2000
Weight (typ., kg)	1300	1800	2300	2500

\* alternative multi-axis configurations optional \*\* others available on request

- All ficonTEC systems are compatible with PXI-based electro-optical instrumentation modules and leveraging of NI's LabVIEW™. Non-LabVIEW and alternative instrumentation environments are also compatible.
- In addition to all driving align-&-attach processes, PCM software also includes AI-based Deep Learning defect recognition capability, optional ML-oriented production data monitoring, and can direct call functions in Python files.
- Custom systems and special purpose cells can be flexibly incorporated to suit customer requirements.